# F CEMOS Technology



Feature Application: Renewable Energy Inverters

Application Guide High Voltage Superjunction MOSFET

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### 1. Scope:

This Application Note supplies information about IceMOS Technology's high voltage Super Junction MOSFET products containing electrical characteristics and proposed application circuits. The Application Note is intended for Engineers involved in the design of circuits for power module products.

### 2. Electrical Characteristics

### 2.1 Maximum ratings

### Example of ICE20N170 (Tj=25°C)

**Maximum ratings** , at  $T_j$ =25°C, unless otherwise specified

Parameter	Symbol	Condition	Value	Unit
Continuous drain current	I <sub>D</sub>	T <sub>c</sub> =25°C T <sub>c</sub> =100°C	20 11	А
Pulsed drain current	I <sub>D, pulse</sub>	<i>T</i> <sub>c</sub> =25°C	62	А
Avalanche Energy, single pulse Eas=1/2*L*I^2(VbrDSS/(VbrDSS-Vbss))	E AS	<i>I</i> <sub>D</sub> =10A	520	mJ
MOSFET dv/dt ruggedness	d <i>v</i> /d <i>t</i>	V <sub>DS</sub> =480V, <i>I</i> <sub>D</sub> =5A, <i>T</i> <sub>j</sub> =125°C	50.0	V/ns
Avalanche current, repetitive	l ar	limited by <i>T</i> jmax	10	А
	V	Static	±20	V
Gale source vollage	VGS	AC ( <i>f</i> >1Hz),	±30	V
Power dissipation	P <sub>tot</sub>	T <sub>c</sub> =25°C	236	W
Operating and storage temperature	$T_{\rm j}, T_{\rm stg}$		-55 to +150	°C
Mounting torque <sup>a</sup>		M 3 & 3.5 screws	60	Ncm

a When mounted on 1inch square 2oz copper clad FR-4

### 2.1.1 E<sub>AS</sub> Avalanche Energy

E<sub>AS</sub> Avalanche Energy is the energy surge when the MOSFET is switched off due to Induced Current flow from Inductance(L) it is illustrated below as a simple equation

### E=L\*di/dt

In the test circuit, ON time was adjusted to create Inductance(L) and keep a certain level of current energy. The current was then forced through the Test device at switch off. This test is called a UIS Test (Unclamped Inductive Switching) providing the amount of energy the device can survive by test giving an indication of the device robustness.





Fig.2 Example of UIS circuit



### 2.1.2 MOSFET dv/dt ruggedness

The Parasitic npn bipolar transistor in the SJMOSFET is shown in Fig4.

When the voltage is changed with dv/dt at Turn off, Current flows through Capacitor C and Resistor R. Since this current creates a Voltage due to the resistance the gate of the parasitic npn bipolar transistor may turn ON and further current may flow which may lead to MOSFET destruction by this phenomenon.





Fig.3 Parasitic npn Transistor





Fig.5 Trr waveform at Reverse recovery

Time Ratio Tb/Ta could be soft recovery index.



Fig.6 Switching circuit example. When the Current flows through MOS2 and is then turned off, IF current flows through MOS1. When MOS2 is turned on again, this current flows through MOS2, the voltage of the body diode of MOS1 rises showing reverse recovery operation, and current waveform is shown by this change of dv/dt in Fig5.



### 2.2 Thermal Characteristics

Paramotor	Symbol	Conditions		Values			
T di diffeter	Symbol	Conditions	Min	Тур	Мах	Om	
Thermal characteristics							
Thermal resistance, junction- case <sup>a</sup>	R <sub>thJC</sub>		-	-	0.53	°C/	
Thermal resistance, junction- ambient <sup>a</sup>	R <sub>thJA</sub>	leaded	-	-	62	W	
Soldering temperature, wave soldering only allowed at leads	T <sub>sold</sub>	1.6mm (0.063in.) from case for 10 s	-	-	260	°C	
	TA Rt Die Rtf Tc	Outside air temperature hJA Ptot unction temperature hJC Case temperature	= * =(1 23	1*Rma 150-25 5.8491	x*Tc= 5)/0.53	(TJ-Tc	)/Rth

Fig.7 Definition of each temperature point and how to calculate Power dissipation  $P_{TOT}$ .  $P_{TOT}$  can be calculated based on  $R_{thJC}$ .

### 2.2.1 Guidelines for soldering

(Refer to Lead free process by JSTD020/JSTD-020)

Method	Solder Temperature	Duration time	Times
Flow/ Reflow	260°C MAX	10 sec MAX	2 times
Soldering iron	380°C MAX	3 sec MAX	1 time







### 2.3 Static Characteristics (DC characteristics) (Tj=25°C) 1 :Temperature dependent

Parameter	Symbol	Conditions			unit
	Cymzer	oonantono	Min	Тур	Мах

### **Electrical characteristics** , at $T_i=25^{\circ}C$ , unless otherwise specified

Static characteristics	Static characteristics										
Drain-source breakdown voltage I Relationship with P and N Charge balance , R <sub>DS</sub> ON	V <sub>(BR)DSS</sub> V <sub>GS</sub> =0 V, I <sub>D</sub> =250uA		600	650	-	V					
Gate threshold voltage Affect switching performance	$V_{\rm GS(th)}$	V <sub>DS</sub> =V <sub>GS</sub> , <i>I</i> <sub>D</sub> =250μA	2.1	3	3.9						
Zero gate voltage drain		V <sub>DS</sub> =600V, V <sub>GS</sub> =0V, <i>T</i> <sub>i</sub> =25 <sup>°</sup> C	-	0.1	1						
current g	IDSS	V <sub>DS</sub> =600V, V <sub>GS</sub> =0V, <i>T</i> <sub>j</sub> =150°C	-	100	-	μΑ					
Gate source leakage current	I <sub>GSS</sub>	$V_{\text{GS}}$ =±20 V, $V_{\text{DS}}$ =0V	-	-	100	nA					
Drain-source on-state resistance	R <sub>DS</sub>	V <sub>GS</sub> =10V, <i>I</i> <sub>D</sub> =10A, <i>T</i> <sub>j</sub> =25 <sup>°</sup> C	-	0.17	0.199						
Important parameter for <b>on</b> -state power loss	(on)	V <sub>GS</sub> =10V, <i>I</i> <sub>D</sub> =10A, <i>T</i> <sub>j</sub> =150°C	-	0.49	-	Ω					
Gate resistance	R <sub>G</sub>	<i>f</i> =1 MHZ, open drain	-	3.8	-	Ω					



RdsON is total summary of Below Resistance : Rcs: Source contact Resistance RN+: Source N+ Resistance RCH: Channel Resistance RD: Drift Resistance(Main resistance) RJFET: JFET Resistance RA: Accumulation Resistance RSUB: Substrate resistance RCD: Drain Contact Resistance

### Fig. 9 The Components of ON Resistance





Fig 10  $V_{GS}$ -I<sub>DS</sub> Characteristic

Voltage beyond  $V_{GS(th)}$  can flow a Drain- Source current. Current can be different depending on the Temperature.







Fig.12 R<sub>DS(ON)</sub> Vs  $T_J$  Junction temperature.

Fig.13  $I_D - R_{DS(ON)}$ 





Fig.14: V<sub>DS</sub>-I<sub>D</sub>

By raising Gate Voltage over  $V_{GS(th)}$ , the drain current flows depending on the Drain Voltage.



Fig.15: V<sub>DSS</sub>-I<sub>DSS</sub>

When a voltage is applied between the drain and source when Gate voltage =0V, an Avalanche current begins to flow, and the voltage that reaches the specified current at that time is the breakdown voltage ( $V_{(BR)DSS}$ )



Fig.16  $V_{(BR)DSS}$  Vs T<sub>J</sub> Junction temperature. At 25°C the normalized ratio for  $V_{(BR)DSS}$  as  $V_{DSS}$  is 1 this subsequently increases with increasing temperature.



Fig.17  $V_{GS}$ -  $R_{DSON}$ The graph shows the required  $V_{GS}$  voltage for  $I_D$ =10A and the corresponding  $R_{DS(ON)}$  value.



### 2.4 Dynamic characteristics (AC characteristics) (Tj=25°C) 1 :temperature dependability

Parameter	Svmbol	Condition		Unit		
	eye		Min	Тур	Мах	

### Dynamic characteristics

Input capacitance	Ciss		V <sub>DS</sub> =25 V	-	2064	-		
Output capacitance	C <sub>oss</sub>	V <sub>GS</sub> =0 V, <i>f</i> =1 M⊔-7	V <sub>DS</sub> =100 V	-	87	-	pF	
Reverse transfer capacitance	C <sub>rss</sub>		V <sub>DS</sub> =25 V	-	18	-		
Transconductance	<b>g</b> fs	V <sub>DS</sub> >2*I <sub>D</sub> *I	R <sub>DS</sub> , I <sub>D</sub> =10A	-	17	-	S	
Turn-on delay time	t <sub>d(on)</sub>		-	23.2	-			
Rise time	<i>t</i> <sub>r</sub>	$V_{DS}=380V$	-	11.8	-			
Turn-off delay time	t <sub>d(off)</sub>	/ <sub>D</sub> =10A (Exte	_	92.5	-	115		
Fall time	<i>t</i> f		,	-	3.9	-		





Fig. 18  $C_{iss}$ ,  $C_{oss}$ ,  $C_{rss}$  vs  $V_{DS}$ 





Fig20. Equivalent circuit for capacitance with labelled parameters: C<sub>iss</sub>, C<sub>oss</sub>, C<sub>rss</sub>



### Fig21. Switching waveform for the case of ICE20N170 at Id 10A.



Td (on) (ns)		tr (ns)	Td (off) (ns)	Tf (ns)	Condition
	23.0	11.5	82.2	5.5	VDS=380V VGS=10V ID=20A Rg=4ohm (external)
	23.2	11.8	92.5	3.9	VDS=380V VGS=10V ID=10A Rg=4ohm (external)

There is no significant difference in the measured Id current at max 20A or 10A For switching.

Maximum frequency is 380kHz at 50% duty cycle. (Safety Ratio is not applied in this case)





### 2.5 Gate Charge Characteristics and Body Diode Characteristics $(T_j=25^{\circ}C)$ $\downarrow$ :temperature dependent

Parameter	Symbol	Conditions		Value		Unit
T di diffeter	Gymbol	conditions	Min	Тур	Мах	onne
Gate charge characteristics				-	-	-
Gate to source charge	Q <sub>gs</sub>		-	8	-	
Gate to drain charge Affect to switching characteristic	Q <sub>gd</sub>		-	19	-	] nC
Gate charge total Affect to drive loss by Gate voltage	Qg	V <sub>DS</sub> =480V, <i>I</i> <sub>D</sub> =20A, V <sub>GS</sub> =10V	-	59	-	
Gate plateau voltage	V <sub>plateau</sub>		-	4.2	-	v
Reverse Diode (Body diode between source and Drain)						_
Continuous forward current as source current This is Body diode Forward current as Max.	I <sub>S</sub>	V <sub>GS</sub> =0V	-	-	20	A
Diode forward voltage Voltage when forward current flow in body diode.	$V_{\rm SD}$	V <sub>GS</sub> =0V, <i>I</i> <sub>S</sub> = <i>I</i> <sub>F</sub>	-	0.9	1.2	V
Reverse recovery time Time to disappear reverse recovery current.	t <sub>rr</sub>		-	358	-	ns
Reverse recovery charge Charge to disappear reverse recovery current	Q <sub>rr</sub>	V <sub>RR</sub> =480V, <i>I</i> <sub>S</sub> = <i>I</i> <sub>F</sub> , d <sub>iF</sub> /d <sub>t</sub> =100 A/μS	-	6.8	-	μC
Peak reverse recovery current	I <sub>rm</sub>		-	43.1	-	Α

### Source-Drain Diode Forward Voltage



Fig.22  $V_{\text{SD}}$  vs  $I_{\text{S}}$  as IF of Body Diode







### Fig.23 Gate Charge Qgs=Qg-Qgd Qgs=Qgs1+Qgs2

When a constant current is applied to the Gate, the Gate Voltage rises and the MOSFET turns ON. Charges are charged between Gate and source, and Gate and Drain during the mirror term. Total Gate Charge Qg is give by Total Gate Current x Time.

Lower Qg correlates to less Gate drive losses.

**FOM** :Figure Of Merit is used as a performance index for Power MOSFETs.

FOM= $R_{DS (on)} \times Qg (\Omega.nC)$ A Lower FOM is superior.

2.6 Safe Operating Area (SOA)



### Fig.24 Safe Operating Area Product shall be used within Idmax ,R<sub>DS(ON)</sub>, Package and BVDSS

This figure is based on a temp= $25^{\circ}$ C Illustrating that the SOA range narrows as the case temperature T<sub>c</sub> rises.

Example : Pulse=10µsec, Tc=75degC to estimate SOA.

Derating Rate D= (150 – Tc) /125\*100

For the point, 16A\*600V=9600W, D=0.6 Pd(75)=P(25)xD = 9600x0.6 =5580W

Therefore the Yellow line could be SOA area for 10µsec,Tc=75degC



### 2.7 Transient Thermal Response



Transient Thermal Response, Junction-to-Case

Fig.25 Transient Thermal Resistance r (t)-pulse width time
t1=Pulse Width=PW
t2=Total Time
Duty=t1/t2
To calculate Channel temperature increasing ΔTch, refer to Fig24 for value of r(t). ΔTch=P\*r(t)

Example 1 Pulse width t1 PW=10ms, D=0.2 (Duty Cycle=20%) How much temperature is increased when Power consumption=60W?

From the graph, 10ms with D=0.2 is for r(t)=0.6  $\$  Rthjc=0.69degC/W  $\Delta$ Tch=P\*r(t)=60x0.6x0.69=24.84°C

Example 2 Condition: Tc=85°C, Power=40W, Pulse Time=10ms, Single Pulse How much temperature of Tj?

```
Tc=85degC,Rthjc=0.69degC/W, P=40W,Duty=0, r(t)=0.5

\DeltaTch=P*r(t)=40x0.5x0.69=13.8°C

Tj=Tc+P*r(t)=85+(40x0.5x0.69) =98.8°C
```

```
Example 3 Condition: Tc=85°C, Frequency=2kHz, Duty Cycle=20%,
Peak Power=50W, How much temperature of Tj?
Tc=85degC, Rthjc=0.69degC/W, P=50W, Duty=0.2, f=2kHz
r(t)=0.24 Pulse width=Duty*1/f=0.2/2000=1E-4sec
Tj=Tc+P*r(t)=85+(50x0.24x0.69) =93.28°C
```



### 3. Product Family

### 3.1 Product List

GEN	Product	BVDSS Min. (V)	ID Max. (A)	RDSON Max. (Ω)	Qg Typ. (nC)	FOM (Ω• nC)	IAR (A) Avalanche	Package *Pbfree TO=T0220* FP=Full Pak* W=T0247* D=T0252 L=DFN B=T0263
							Current	C=Wafer*
	ICE47N60	600	47	0.068	189	12.85	20	W,C
	ICE60N130	600	25	0.15	84	12.60	11.5	TO,FP,W,C
	ICE22N60	600	22	0.16	84	13.44	11	то, в ,W
	ICE20N170	600	20	0.199	59	11.74	10	TO,FP,W,C,B
1	ICE20N60	600	20	0.19	59	11.21	10	TO,FP,W,B,C
	ICE19N60	600	19	0.22	59	12.98	9.5	L8x8
	ICE15N60	600	15	0.25	59	14.75	7.5	TO,FP,W,L8x8
	ICE11N70	700	11	0.25	84	21.00	7.5	TO,FP,W,B,C
	ICE10N60	600	10	0.33	43	14.19	5	TO,FP,W,B,L8x8
	ICE32S60	600	32	0.078	47	3.67	10	TO,FP,W,C
	ICE25S65	650	25	0.133	34	4.52	8	TO,FP,W,C,B
2	ICE24S65	650	24	0.141	34	4.79	8	L8x8
2	ICE15S60	600	15	0.175	30	5.25	5	TO,FP,W,C,B
	ICE14S65	650	14	0.195	24	4.68	5	TO,FP,W,C,B
	ICE8S65	650	7.8	0.4	11.5	4.60	2.7	TO,FP,W,B,C,L5x6
	ICE117T60*	600	117	0.0134	304	4.07	13	Wplus
3	ICE18T60*	600	18	0.15	31	4.65	5	TO,FP,W,B,D,C,L5x6
	ICE15T65*	650	15	0.22	23	5.06	2	TO,FP,W,,B,D,C,L5x6

### 3.2 Output Power Range of DCDC Converter by Product Type



Circuit choice may be different depending on the output power. Full bridge may have over 1700W Power therefore please select the appropriate product depend on the power range. For example, the case of 100W Fly back , we offer ICE20N170 for Max Id=20A or ICE15S60 for Max Id=15A.

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### 4.0 "Where Used Applications Matrix"

### 4.1 Application Matrix $\star$ : Displays the circuit used for each application

Output Circuit												
#	Application	Power (	N)		AC-DC			D	C-DC		DC-AC	ICEMOS
		Min	Max	Half wave	Full Wave1	Full Wave2	Fly back	For ward	LLC Half Bridge	Full Bridge	Inverter	Product
al	SMPS Power Factor Correction	500							*	*		ICE25S65 ICE60N130
a2	LLC Half Bridge	1000								*		ICE47N60 ICE32S60
b	Low power SMPS Quasi- Resonant		100				*					ICE15S60 ICE20N170
с	High Power SMPS	500	1500						*			ICE47N60
d	ATXPower Supplies	200	1600	*	*	*	*	*	*			ICE47N60
e1	LED TV	5k- 140inch				*				*		ICE117T60 ICE47N60
e2	LED Lighting	20	500	*	*	*	*	*				ICE25S65 ICE60N130
f	Data center AC/DC(Severs and Telecom)	500k-1k node				*				*		ICE117T60 ICE47N60
g	Fast Chargers	3k	400k			*				*		ICE117T60 ICE47N60
h	Chargers PC Adapters	36	90	*	*		*					ICE15S60 ICE20N170
i	TV Power application	24	410		*	*	*	*				ICE25S65 ICE60N130
j	UPS	500	10k			*			*	*	*	ICE117T60 ICE47N60
k	Solar inverters	300	6k					*	*	*	*	ICE117T60 ICE47N60
I	HID Street lights	22	500			*		*	*			ICE25S65 ICE60N130
m	Gaming consoles	100	200		*	*		*				ICE60N130 ICE20N170
n	LED signage	10	250	*	*			*				ICE60N130 ICE20N170
0	E bikes E-Mobility	600	40k			*			*	*		ICE117T60 ICE47N60
р	Printers	10	1500	*	*	*	*	*	*	*		ICE117T60 ICE47N60
q1	White good Fridge	200	300			*			*	*	*	ICE60N130 ICE20N170
q2	Washing machine	800	1500			*			*	*	*	ICE117T60 ICE47N60
r1	Audio Amp	200 x n	5k x n			*			*	*		ICE117T60 ICE47N60
r2	Projector	300	2k			*		*	*	*		ICE117T60 ICE47N60
s1	Car audio	10 x n	100xn				*	*				ICE47N60 ICE32S60
s2	Navigation	10	20				*					ICE15S60 ICE20N170
u	3D printer	180	1500	*	*	*	*	*	*	*		ICE117T60 ICE47N60
V	Smart phone adaptors	20	90	*	*		*					ICE15S60 ICE20N170
W	Factorized power	320	1300			*			*	*		ICE117T60 ICE47N60
х	Tablet computers	200	1500	*	*		*					ICE15S60 ICE20N170
у	Micro Inverters	200	1500						*	*	*	ICE117160 ICE47N60



### 4.2 Circuits

4.2.1 Full Bridge Converter (Isolated)

## **Example of Server Management**



4 pieces used of ICE47N60 or ICE32S60

4.2.2 LLC Resonant Half Bridge Converter (Isolated)

# LLC Resonant Half Bridge Converter

2 pieces used of ICE60N130 or ICE25S65



### 4.2.3 Forward Converter (Isolated)



### 1 piece used of ICE20N170 or ICE60N130

This system can supply a wide range of power. Compared to the flyback converter an additional diode and choke coil are required but the ripple voltage is lower. The output voltage is determined by the ratio of the number of turns on the primary and secondary sides.

### 4.2.4 Flyback converter (isolated)



### 2 pieces used ICE15S60 and ICE20N170

Since the ripple voltage is larger compared to the other converters, a larger capacitor is required. The output voltage is determined by the ratio of the number of turns on the primary and secondary sides.



# 5. Feature Application: Renewable Energy Inverter -Solar application **Solar Inverter Technology**

Typical inverter topology designs can be characterized by one of two features, topology and power switch control. The topology can be single or double ended, while the control may be self-oscillating or driven by a separate circuit. The preferred approach depends on performance required versus cost objective.

Single ended topologies have fewer power switches and associated circuits than double ended topologies. They are therefore less expensive. However, the transistor used as a power switch in a single ended topology must carry the entire load, in terms of current and voltage. Hence, single ended designs require transistors with greater current capacity and higher breakdown voltage rating than the double ended designs. These requirements suggest using a bipolar transistor. However, this limits the topology to low frequency operation. The Superjunction MOSFET is an excellent solution to this problem. The low R<sub>DS (on)</sub> of the Superjunction devices allow the current carrying capability to compete with the Bipolar Transistor. The fast-switching speed of the MOSFET and the simple drive circuit makes the Superjunction Transistor the device of choice for single ended ballast topologies.

Double ended inverters use at least two power switches. As a result, each power transistor carries all of the load current, but only half the voltage. In other topologies the transistor carries half the load current, but all the voltage. Again, MOSFETs are the transistor of choice for this topology and because of the superior R<sub>DS (on)</sub>, simple drive circuit the Superjunction Power MOSFET ideal for this application.

The inverters work by taking in power from a Direct Current (DC) Source, in this case the solar panels. The power is generated in the range of 250 Volts to 600 Volts. DC power is converted into AC power by the inversion process taking place in the inverter. This process of DC to AC Conversion is achieved by using a set of solid-state devices like Insulated Gate Bipolar Transistors (IGBT's) or Power Superjunction MOSFETs. These devices when connected in a typical H-Bridge arrangement oscillate the DC power thereby creating AC power.

# TYPICAL SOLAR PANEL SYSTEM



Solar Inverter System Illustration (Source: Herholdt's Group (Pty) Ltd.)



### System diagram for Solar designs up to 6kW



For DCDC, a single booster is usually used. and for DCAC, there are three methods for DCAC block.

	Product	BVDSS	ID	RDSON	Qg	Pd	FOM	Rthjc	IAR	Package
		Min.	Max.	Max.	Тур.	(W)	(Ω•	(degC/W)	(A)	TO=T0220
GEN		(V)	(A)	(Ω)	(nC)		nC)			FP=Full Pak W=TO247
0.2.1									Avalanche	D=T0252
									Current	8=DFN8x8
									Carlone	C=Wafer
1	ICE47N60	600	47	0.068	189	431	12.85	0.29	20	W,C
	ICE54T60FDW		= 4	0.007	100	0.5.5		0.10	_	14/
3	fast recovery	600	54	0.037	136	255	5.03	0.49	1	VV



### 6. Charging Power for Electric Vehicle and Home Products

Quick chargers for EV have several connector shapes, communication methods(e.g. CAN and PLC) and maximum power outputs (1000Vx400A=400kW, 950Vx250A=237.5kW, 410Vx330A=135kW respectively). In the case of Slow chargers, there are two main types 3kW and 7kW used primarily for home charge with some public use. The 3kW slow charger takes 12-13 hours to reach full charge with the 7kW taking 6 hours. For a 50kW (125A) Quick DC charge , it can take as little as 20 minutes to 1hour for an 80% Power charge. As recent trends indicate that battery capacity shall increase, new electric vehicles will need ultra-rapid chargers that exceed 100kW for Fast Charge.



In stations that charge several electric vehicles simultaneously, it is necessary to connect 15kW~30kW charger units in parallel to output 100kW or more.

Our GEN3 product currently under development ICE117T60 has a BVDSS of 600V in a TO247 package enabling a 15~30kW system. For a 100kW ultra-rapid charger the important parameters shall be low R<sub>ds(on)</sub> and Pd(W).

	Product	BVDSS	ID	RDSON	Qg	Pd	FOM	Rthjc	IAR	Package
		Min.	Max.	Max.	Тур.	(W)	(Ω•	(degC/W)	(A)	TO=T0220
		(V)	(A)	(Ω)	(nC)		nC)		<b>、</b>	FP=Full Pak
GEN			( )		( - )		- /			W=T0247
									Avalanche	D=T0252
										8=DFN8x8
									Current	C=Wafer
3	ICE117T60*	600	117	0.0134	304	624	4.07	0.2	13	Wplus

IceMOS can offer both wafer and die level sales so you can freely design your package or module type by combining several devices for 1 package.



### 7. Data Center Power Management Stages



### **Device Specifications For Power Management In Data Center Servers**

Product	ICE47N60W	ICE20N170	ICE60N130
Stage	ICP	PFC	DC/DC
ld (MAX)	47A	20A	25A
V(BR)DSS (MIN)	600V	600V	600V
RDS(on) (TYP)	0.06Ω	0.17Ω	0.14Ω
Qg (TYP)	189nC	59nC	72nC

The IceMOS GEN-1 Superjunction MOSFET technology is a high performance, reliable, costeffective solutions for data center power supplier designers.

- ✓ Superior Avalanche Energy (EAS) performance IceMOS GEN-1 devices are designed to be a more robust power MOSFET.
- ✓ Device Versatility The ICE47N60W N-channel device is one of the most popular devices selected by circuit designers because of its versatility. This device is used in high performance power system and in AC-DC, DC-DC and DC-AC circuits.

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### 8. Failure Modes of Power MOSFETs.

There are 3 main failure modes as below:

### 8.1 Avalanche Failure (UIS failure)

The device will be destroyed by a voltage / current load that exceeds the E<sub>AS</sub> capacity to withstand when switching off, such as in an L load circuit. Phenomenon such as VG(th) deterioration and short circuit between drain and source are confirmed. It is also necessary that the channel temperature Tj in the avalanche state is 150°C or less.

8.2 EOS Failure (Electrical Over Stress outside SOA or beyond Voltage or Current) When devices experience stresses beyond their safe operating range such as voltage surge, excess current or thermal stress resulting in a damaged device. In this mode metal burn marks can be visible over die surface and the silicon might be melted. The three 3 pin terminals(Gate-Drain-Source) could short circuit. Our product has been tested to failure by a Class 2 1000V Voltage Surge from a IEC61000-4-5 Surge Generator resulting in burn marks around the Gate and Source pads.

8.3 ESD Failure(Electro Static Discharge)
Our SJMOSFET ESD capacity is classified by MIL-STD-1686 as below:
Human Body Model Class 3 (4000-15999V)
Machine Model Class M5 > +-800V

ESD can cause problems such as gate leaks due to polysilicon or gate oxide film destruction, and resistance shorts between drain and source. When handling, ESD such as  $1M\Omega$  grounding and applying Anti static Discharge action to the Equipment.





### 9. Reliability Test Results

Items	Test Description(Abbr.)	Test method.	Stress Condition	Result
1	Temperature Cycle(TCT)	JESD22-A104	1000 cycles, Δ Tj -55 to 150°C	PASS
2	High Temp storage(HTS)	Mil-Std. 750 Method 1032	500 hrs, Tj = 150°C	PASS
3	Steady State Gate Bias positive (HTGB)	Mil-Std. 750 Method 1042-B	1000 hrs, VGS = $+24V$ Tj = $150^{\circ}C$ PAS	
4	Steady State Gate Bias negative (HTGB)	Mil-Std. 750 Method 1042-B	1000 hrs, VGS = -24V Tj = 150°C	
5	Steady State Reverse bias (HTRB)	Mil-Std. 750 Method 1042-A	1000 hrs, VDS = 480V Tj = 150°C	
6	High Temp Hugh Humidity Reverse Bias (H3TRB)	Mil-Std. 750 Method 1042-A	1000 hrs, VDS = 480V Tj = 85 °C, RH = 85%	PASS
7	Pressure Cooker Test (PCT)	Method JESD22-A102	121C 100% RH, 205Kpa,96 hours	PASS
8	Highly Accelerated stress test (HAST)	JESD22-A110D	130°C 85% RH, 230Kpa, 96 hours	PASS
9	Resistance to Solder Heat Test (RSH)	JESD22- B106(PTH)	265°C 10-12secss 3 cycles	PASS
10	Solderability	JESD22-B102E	260°C 10 secs	PASS

### 10. Marking Rules



YY=Last two digit in Year WW=Work Week \* Manufacturing site ID XXXXX =Production lot ID ICEXX X XX =ICEMOS Product name X=N: GEN1, S: GEN2, T:GEN3



### 11. New Package Introduction – DFN 8X8



DFN 8x8 Leadless Package

### Features:

- Low On-resistance
- Ultra Low Gate Charge
- High peak current capability
- High dv/dt capability
- Tape & Reel packaging (13 inch reel)
- 3,000 units per reel size
- Eco-Friendly, MSL-1

### Applications:

- ✦ Servers ✦ Adapters ✦ HID Lighting
- ♦ UPS ♦ Renewable Energy

### Benefits:

A

PN #1 .D

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⊖ ggg@ A B

✓ Ideal For High Density Applications

// ccc C

✓ Ideal For High Speed Automated Production

U

W

SEATING PLANE

EXPOSED PAD

✓ Low Profile Leadless Package

D

D2 ⊕0.1C AB



DFN8x8

Part Number	GEN1	GEN2	GEN2	
r art Number	ICE19N60L	ICE15S60L	ICE25S65L	
Polarity	Ν	N	Ν	
ld(Max)	19A	15A	25A	
V(BR)DSS(Min)	600V	600V	650V	
Rds(on)(Typical)	0.20Ω	0.155Ω	0.120Ω	
Qg(Typical)	59nC	30nC	34nC	
FOM(ΩxnC)	11.8	4.65	4.08	

### Release plan is early Q3 on GEN1, Q4 on GEN2







### 12. PACKAGE information



Package:

- RoHS Directive (EU)2015/863
- Lead Free( Pb free ) product.(except some of surface mount)
- Halogen Free
- Eco-Friendly Mold Compound

Our Pb free definition is no use of Pb for any device inside and outside.







	$\sim$ Guidelines for Handling our SJ MOSFET $\sim$
•	Soldering Temperature Flow /Reflow : 260°CMax 10 sec 2 times iron soldering : 380°CMax 3 sec 1 time
2	. Shelf Life Guideline: Packaged product 5 years Wafer form 3 years
3	. Avoid sudden temperature changes and store at a Temp $5\sim35^{\circ}$ C and a humidity of $20\sim75\%$ RH $$ The moisture Sensitive Level of TO220,TO220FP and TO247 is MSL1. DPAK,D2PAK,DFN8x8 and DFN5x6 is MSL3.
4	Please keep away from ccorrosive, chloride, excessive weight and direct sunlight as the product quality may degrade so please avoid these conditions for your storage.
5	. To prevent damage from static electricity (ESD) store the product in an ESD-resistant package. When handling the device ground the jig, device, bench etc.
6	. Our products comply with RoHS and REACH. We do not use any minerals from conflict zones

### **Contact:** IceMOS Sales: <u>sales@icemostech.com</u>

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